

## Notice of References Cited

Application/Control No.

O9/575,342

Examiner

Tuan A Vu

Applicant(s)/Patent Under
Reexamination
RAPAKKO ET AL.

Art Unit
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## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,405,362	06-2002	Shih et al.	717/174
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	D	US-			
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## **NON-PATENT DOCUMENTS**

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